

# Real-time tracking of fast superparamagnetic nanoparticle self-assembling by focused synchrotron beam

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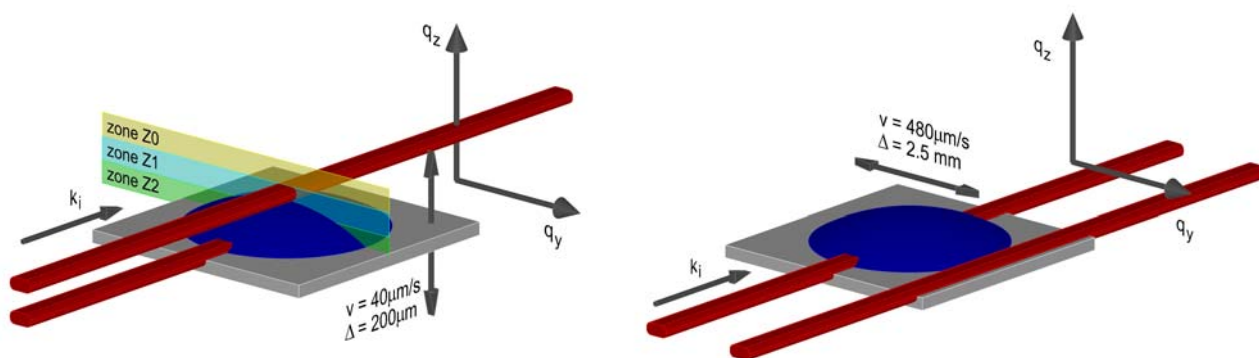
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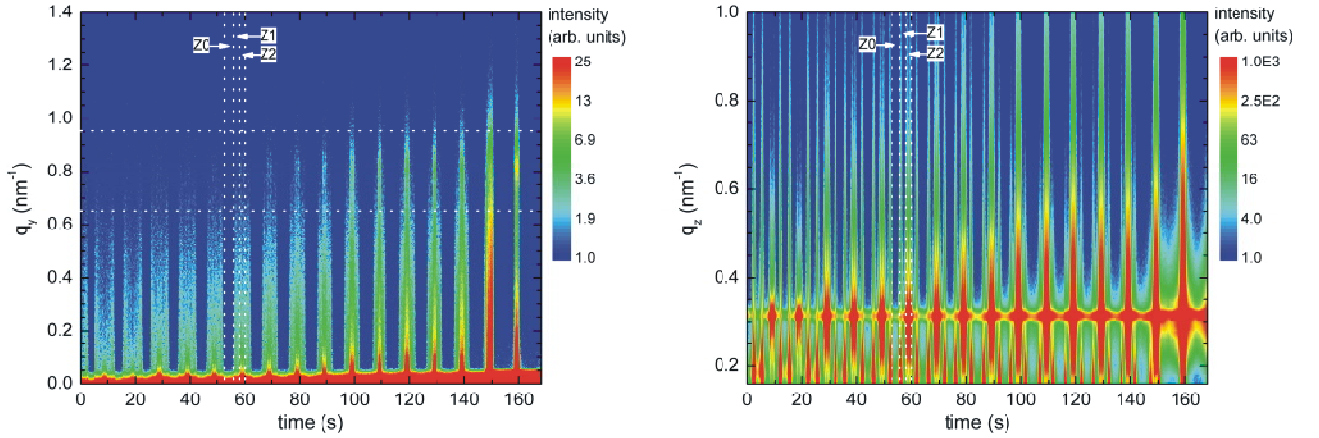
Latest advances in nanochemistry made possible the synthesis of highly monodisperse colloidal nanoparticles. In particular, magnetic nanoparticles become increasingly important in applied materials science (bio-applications, emerging spintronic devices, etc.). Well correlated nanoparticle templates result from the process of spontaneous nanoparticle self-assembly which is a fast and cost effective way of fabrication of nanoparticle monolayers. Here we report on a real time observation of the spontaneous self-assembly process of superparamagnetic Fe<sub>3</sub>O<sub>4</sub> nanoparticles in a fast drying colloidal drop by grazing-incidence small-angle X-ray scattering (GISAXS). The experiments were conducted at BW4 beamline at HASYLAB. The focused X ray beam of the size 65 x 35 μm<sup>2</sup> and the wavelength of 0.138 nm hit a silicon substrate at 0.2° grazing angle of incidence. The X ray camera PILATUS 100K with the read-out time of 3 ms between subsequent frames and the pixel size of 172 x 172 μm<sup>2</sup> was used at a distance of 225 cm from the sample. The exposure time of a frame was set to 25 ms. The colloidal drop was applied manually on the silicon substrate. The zero of the time scale is related to the activation of the hutch interlocks and has some 30 s delay with respect to the drop application. In these measurements, the absolute time scale is not relevant. To relate time evolution of the reciprocal space and direct space features and to localize the nanoparticle self-assembling, vertical or horizontal sample oscillations were applied (Fig. 1).



**Figure 1.** Vertical and horizontal scanning schemes.

In the first stage after application, the drop wets the substrate and the drop contact line reaches its maximum diameter. The second stage is dominated by a linear decrease of the drop mass accompanied by a shrinking of the drop contact line. The nanoparticles serve as pinning centers which can be observed as a gradual *stick-slip* motion of the drop contact line. The third stage starts when the evaporation-driven surface tension instability initiates random drop movement along the substrate. In this study, we addressed mainly the second evaporation stage that is responsible for self-assembling. In the zone Z0 (Fig. 1), the sampling beam is located above the drop surface and only a background scattering is recorded. The limits of the zone Z1 are defined by the first contacts of the beam with the drop surface and the substrate. Here, the scattering is due

solely to the drop near-surface region and drop volume. The zone Z2 produces a combined scattering by the drying drop and the substrate. The zone Z1 plays the major role in this study since it gives an unambiguous determination of the scattering volume. The GISAXS pattern recorded after a complete solvent evaporation exhibits side maxima at  $q_y \approx \pm 0.82 \text{ nm}^{-1}$  produced by the self assembled nanoparticle areas and a central streak along  $q_z$  at  $q_y = 0$  coming from the substrate and nanoparticle-related roughness which is usually measured in the  $q_x - q_z$  plane (coplanar geometry) as a detector scan. The GISAXS pattern simulated within the DWBA and paracrystal model provided nanoparticle radius of  $3.4 \pm 0.3 \text{ nm}$ , interparticle distance of  $7.5 \pm 1 \text{ nm}$ , and lateral correlation length of  $87 \text{ nm}$ .

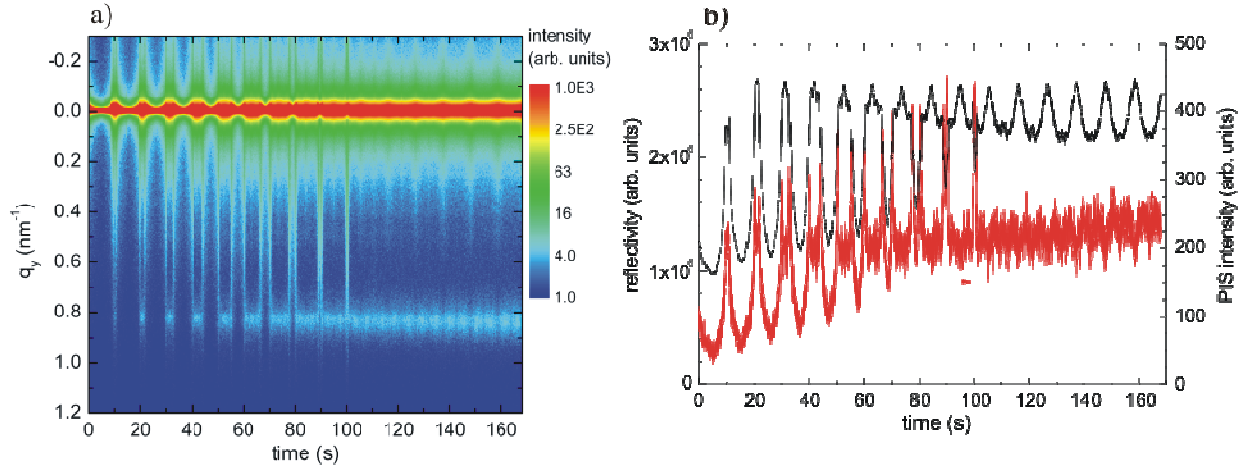


**Figure 2.** The  $t - q_y$  and  $t - q_z$  maps of the drying colloidal drop forming a monolayer in the vertical scanning mode.

The data from time-resolved GISAXS taken on the oscillating sample were processed into two different kinds of maps (Fig. 2). In a so called  $t - q_y$  map, the region between  $q_z = 0.22$  and  $0.4 \text{ nm}^{-1}$  was integrated and plotted as a function of time. In a so called  $t - q_z$  map, integration for  $q_y$  between  $\pm 0.02 \text{ nm}^{-1}$  was performed and plotted as a function of time. Briefly, the  $t - q_y$  map describes the temporal evolution of the  $q_y$  component of the scattering vector near the critical exit angle and the  $t - q_z$  map describes the temporal evolution of what is called above the detector scan. The instances when the sampling X-ray beam comes into contact with the drop surface (Z0→Z1 transition) or when it leaves the drop (Z1→Z0 transition) are clearly visible as an enhanced scattering along  $q_y$  direction in the  $t - q_y$  map for the early evaporation stage (less than 60 s). In between, more absorbed and weaker radiation coming from the zone Z2, where the X ray beam starts to interact with the substrate, can be seen. The Z0→Z1 and Z1→Z0 transitions are marked also by significant scattering in the  $t - q_z$  map while the detector scans in between produced by the substrate scattering in the zone Z2 are less prominent. This behaviour is reversed at later evaporation stages (more than 60 s) where the main scattering stems from the zone Z2 and the substrate scattering plays the major role. It can be observed in the  $t - q_y$  map as a strong scattering signal surrounded by a lower one coming from the zone Z1. Similarly in the  $t - q_z$  map, the detector scans resulting from the Z0→Z1 and Z1→Z0 transitions are decreasing in intensity in favour of the detector scans originating from the substrate scattering in the zone Z2. The temporal approaching of the occurrence of the detector scans (i.e. Z0→Z1 and Z1→Z0 transitions) belonging to one sample oscillation cycle indicates the thinning of the evaporating colloidal drop. Similar temporal plots related to different sample regions can be drawn from the integration of the subsequent GISAXS frames over the square regions around the side maxima and specular reflection. All these analyses imply that the self assembly starts in the vicinity of the drop contact line rather than near the surface or inside the drop. This is in line with our previous observations where no self-assembled clusters were found with measurements in a so called *drop mode* where the incoming beam parallel to the substrate surface probed only the drop volume [1].

To support the assumption about the self-assembling near the contact line, we employed also a horizontal scanning scheme as shown in Fig. 1. Here, the sample oscillates horizontally across the incoming X ray beam which intersects periodically the shrinking drop contact line during the solvent evaporation. The

scanning velocity was adapted to the exposure and read-out times of the X ray camera in order to minimize the effect of the spatial smearing on the scattering volume sampled by the X ray beam. The  $t - q_y$  map measured in the horizontal scanning mode is shown in Fig. 3a. At the beginning, periodic stripes of an enhanced intensity along the  $q_y$  axis with the maximum at  $q_y \approx \pm 0.82 \text{ nm}^{-1}$ , coming from the already dried regions of the self assembled monolayer of nanoparticles and adjacent low-absorbing volume of the drop close to the three-phase contact line, are observed. In between, the sampling X ray beam enters the drop and



**Figure 3.** The  $t - q_y$  map (a) and time-resolved reflectivity (upper curve) and PIS (lower curve) (b) of the drying colloidal drop forming a monolayer in the horizontal scanning mode.

is strongly suppressed in intensity by the drop absorption, showing no correlations between the nanoparticle positions. The peak at  $q_y \approx \pm 0.82 \text{ nm}^{-1}$  persists up to the complete drop evaporation which indicates a well ordered and stable nanoparticle monolayer. The temporal plot extracted from the GISAXS pattern by integration over the region of the side maximum (partial integrated scattering – PIS) is compared with the time resolved specular reflectivity curve in Fig. 3b. The minima in the PIS plot and reflectivity are correlated in the early evaporation stages as both are observed when the probing x ray beam is strongly attenuated inside the drop. As the beam crosses the three-phase contact line and leaves the drop, an enhanced scattering in the PIS plot is observed, followed by a significant increase of the reflectivity signal. The opposite takes place when the beam enters the drop. The reflectivity maxima correspond to extreme positions of the horizontal scan when the maximum area of the bare substrate adjacent to the drop is hit by the probing beam. In between, the reflectivity comes mainly from the already dried areas of the colloidal solution with the nanoparticle-related roughness and is thus inherently lower. On the other hand, these areas contribute to the GISAXS signal which is at maximum in the central part of the scan (i.e. in the drop center) when the drop is evaporated completely. Therefore in the final evaporation stages, the PIS signal reaches a steady-state value with a small oscillating part which is in anti-phase with the reflectivity oscillations. Here, the oscillations in the PIS plot and reflectivity are due to a periodically changing ratio between the illuminated areas favouring reflectivity (bare substrate) and GISAXS (dried nanoparticle monolayer). These measurements indicate that behind the shrinking contact line, the self assembled monolayer is originating. Because no measurable lateral correlations of the nanoparticles near the surface or inside the drop were observed by the vertical scanning, the vicinity of the three phase drop boundary is the location of the nanoparticle accumulation and self-assembling.

1. P. Šiffalovič, E. Majková, L. Chitu, M. Jergel, Š. Luby, A. Šatka, S. V. Roth, *Phys. Rev.*, **B 76**, (2007), art.no. 195432.